

TIC116A, TIC116B, TIC116C, TIC116D, TIC116E, TIC116M, TIC116N, TIC116S

P-N-P-N SILICON REVERSE-BLOCKING TRIODE THYRISTORS

- 8 A Continuous On-State Current
- 80 A Surge-Current
- Glass Passivated Wafer
- 100 V to 800 V Off-State Voltage
- Max I_{GT} of 20 mA
- Compliance to ROHS

ABSOLUTE MAXIMUM RATINGS

Symbol	Ratings	Value							Unit	
		Α	В	С	D	Е	М	S	Ν	
V _{DRM}	Repetitive peak off-state voltage (see Note1)	100	200	300	400	500	600	700	800	V
V _{RRM}	Repetitive peak reverse voltage	100	200	300	400	500	600	700	800	V
I _{T(RMS)}	Continuous on-state current at (or below) 70°C case temperature (see note2)	8					А			
I _{T(AV)}	Average on-state current (180° conduction angle) at(or below) 70°C case temperature (see Note3)					А				
I _{TM}	Surge on-state current (see Note4)	80				Α				
I _{GM}	Peak positive gate current (pulse width ≤300 µs)	3				А				
P _{GM}	Peak power dissipation (pulse width ≤300 µs)	5				W				
P _{G(AV)}	Average gate power dissipation (see Note5)	1				W				
Tc	Operating case temperature range -40 to +110				°C					
T _{stg}	Storage temperature range	-40 to +125				°C				
TL	Lead temperature 1.6 mm from case for 10 seconds	230			°C					

Notes:

1. These values apply when the gate-cathode resistance $R_{GK} = 1k\Omega$

2. These values apply for continuous dc operation with resistive load. Above 70°C derate linearly to zero at 110°C.

3. This value may be applied continuously under single phase 50 Hz half-sine-wave operation with resistive load. Above 70°C derate linearly to zero at 110°C.

4. This value applies for one 50 Hz half-sine-wave when the device is operating at (or below) the rated value of peak reverse voltage and on-state current. Surge may be repeated after the device has returned to original thermal equilibrium.

5. This value applies for a maximum averaging time of 20 ms.

Page 1 of 3



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THERMAL CHARACTERISTICS

Symbol	Ratings	Value	Unit	
t _{gt}	Gate-controlled $V_{AA} = 30 \text{ V}, \text{ F}$ Turn-on time $R_{GK(eff)} = 100$	$R_{\rm L} = 6 \ \Omega,$ 0.8 0, $V_{\rm in} = 20 \ V$	116	
t _q	Circuit-communicated Turn-off time V _{AA} = 30 V, F	$R_{\rm L} = 6 \ \Omega, \ I_{\rm RM} \approx 10 \ {\rm A}$ 11	μs	
R _{∂JC}		≤ 3	°C/W	
R∂JA		≤ 62.5	C/W	

ELECTRICAL CHARACTERISTICS

TC=25°C unless otherwise noted

Symbol	Ratings	Test Condition(s)	Min	Тур	Mx	Unit	
I _{DRM}	Repetitive peak off-state current	V_D = Rated V_{DRM} , R_{GK} = 1 k Ω , T _C = 110°C	-	-	2	mA	
I _{RRM}	Repetitive peak reverse current	V_R = Rated V_{RRM} , I_G = 0, T_C = 110°C	-	-	2	mA	
I _{GT}	Gate trigger current	V _{AA} = 6 V, R _L = 100 Ω, t _{p(g)} ≥ 20μs	-	5	20	mA	
V _{GT}	Gate trigger voltage	V_{AA} = 6 V, R _L = 100 Ω, R _{GK} = 1 kΩ, t _{p(g)} ≥ 20µs, T _C = -40°C	-	-	2.5		
		V _{AA} = 6 V, R _L = 100 Ω, R _{GK} = 1 kΩ, t _{p(q)} ≥ 20µs,	-	0.8	1.5	V	
		V_{AA} = 6 V, R _L = 100 Ω, R _{GK} = 1 kΩ, t _{p(g)} ≥ 20µs, T _C = 110°C	0.2	-	-		
I _H	Holding current	V_{AA} = 6 V, R_{GK} = 1 k $\Omega,$ initiating I_{T} = 100 mA	-	-	40		
		V_{AA} = 6 V, R_{GK} = 1 k Ω , initiating I _T = 100 mA, T _C = -40°C	-	-	70	mA	
V _{TM}	Peak on-state voltage	I _{TM} = 8A (see Note6)	I	-	1.7	V	
dv/dt	Critical rate of rise of off-state voltage	V_D = Rated V_D , T _C = 110°C	-	100	-	V/µs	

Note 6:

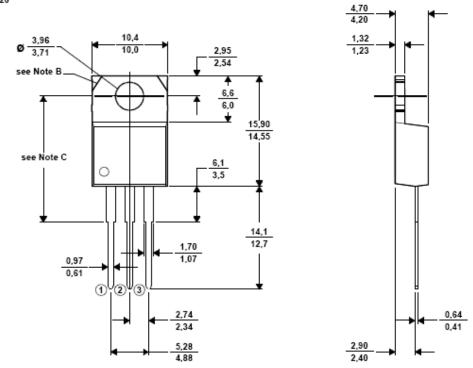
This parameters must be measured using pulse techniques, $t_w = 300 \mu s$, duty cycle ≤ 2 %, voltage-sensing contacts, separate from the courrent-carrying contacts, are located within 3.2mm (1/8 inch) from de device body.

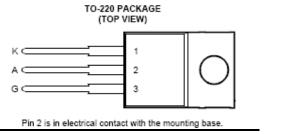


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MECHANICAL DATA CASE TO-220

TO220





Pin 1 :	kathode
Pin 2 :	Anode
Pin 3 :	Gate

Page 3 of 3